

Search Notes				Application/Control No.	Applicant(s)/Patent under Reexamination	
				10/670,545	HSIEH ET AL.	
				Examiner	Art Unit	
				Alford W. Kindred	2163	

SEARCHED			
Class	Subclass	Date	Examiner
707	1, 3	11/8/2005	AWK
705	76-76		
Update			
Abn 3/2/06 Awk			
Update 9/12/06 Awk			
Abn			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
West US, JPO, EPO, IBM, Derwent	11/8/2005	AWK
Update		
Abn	3/2/06 Awk	
Update	9/12/06 Awk	
Abn	9/12/06 Awk	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner